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PATENT
450100-05076

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Takehiko NAKANO et al.
International Application No.: PCT/JP2004/003327
International Filing Date: March 12, 2004
For: DEVICE-TO-DEVICE AUTHENTICATION SYSTEM,
DEVICE-TO-DEVICE AUTHENTICATION METHOD,
COMMUNICATION APPARATUS, AND COMPUTER
PROGRAM

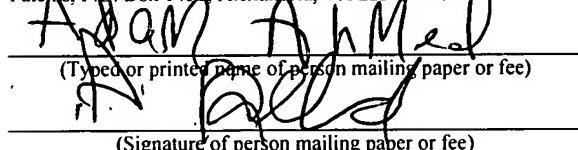
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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP2004/003327. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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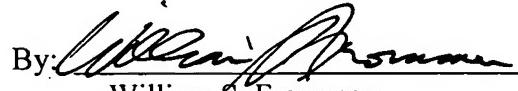
REMARKS

Entry of this Information Disclosure Statement and an early examination on the
merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP
Attorneys for Applicants

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Enclosures

Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-05076	SERIAL NO. Filed Concurrently Herewith
	APPLICANT Takehiko NAKANO et al.	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2001/0054159	12/20/01	Hoshino			
	AB						
	AC						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2002-175224	06/21/02	Japan			
	AM	JP 2002-7233	01/11/02	Japan			
	AN	JP 2003-76805	03/14/03	Japan			
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